Substitute form 1449A/PTO INFORMATION DISCLOSURE				Complete if Known		
				Application Number	To Be Assigned 10/760 966	
				Filing Date	Geneurrently-Herewith 1-20-04	
STATEMENT BY APPLICANT			T	First Named Inventor	Zhibo Zhang	
			•	Group Art Unit	2813	
(use as many sheets as necessary)				Examiner Name	HOGANS	
Sheet 1 of 2			2	Attorney Docket Number	5051-563DV	

			U	S. PATENT DOCUMENTS		
Examiner	Cite No.	U.S. Patent Document		Name of Patentee or Applicant	Date of Publication of	Pages, Columns, Lines, Where Relevant Passages
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\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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